


<b>Search Notes</b>  	<b>Application/Control No.</b>  10541332	<b>Applicant(s)/Patent Under Reexamination</b>  MCDONALD ET AL.
	<b>Examiner</b>  Justin Y Lee	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
455	all	7/23/2008	/JL/

SEARCH NOTES		
Search Notes	Date	Examiner
East	7/23/2008	/JL/
Duc Nguyen	7/23/2008	/JL/
Inventor Search	7/23/2008	/JL/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner